

Notice of References Cited	Application/Control No. 10/765,688	Applicant(s)/Patent Under Reexamination RAUSCHER ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,723,806 B2	04-2004	Van Tol et al.	526/113
*	B	US-6,441,210 B1	08-2002	Van Tol et al.	556/9
*	C	US-6,087,513 A	07-2000	Liao et al.	549/524
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 197 30 376 A1	01-1999	Germany	van Santen et al.	B01J 31/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Severn et al. Organometallics, 2000, 21, 4-6.
	V	Duchateau et al. Organometallics, 1998, 17, 5222-5224.
	W	Skowronska-Ptasinska et al. Organometallics, 2001, 20, 3519-3530.
	X	Wada et al. Organometallics, 2004, 23, 5824-5832.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.